

# **FCC Test Report**

Report No.: AGC00803230701FE03

FCC ID	: 2AKHJ-HD098S-3
APPLICATION PURPOSE	: Original Equipment
PRODUCT DESIGNATION	: Wireless Keyboard
BRAND NAME	: N/A
MODEL NAME	: HD098S-3, HD098S-3G01, UBWDK-01
APPLICANT	: Shenzhen Hangshi Electronic Technology Co., Ltd
DATE OF ISSUE	: Jul. 07, 2023
STANDARD(S)	: FCC Part 15.247
<b>REPORT VERSION</b>	: V1.0







#### **REPORT REVISE RECORD**

Report Version	Revise Time	Issued Date	Valid Version	Notes
V1.0	/	Jul. 07, 2023	Valid	Initial Release



#### **TABLE OF CONTENTS**

1. VERIFICATION OF CONFORMITY	5
2. GENERAL INFORMATION	6
2.1. PRODUCT DESCRIPTION	6
2.2. TABLE OF CARRIER FREQUENCYS	6
2.3. RECEIVER INPUT BANDWIDTH	7
2.4. EXAMPLE OF A HOPPING SEQUENCY IN DATA MODE	7
2.5. EQUALLY AVERAGE USE OF FREQUENCIES AND BEHAVIOUR	7
2.6. RELATED SUBMITTAL(S) / GRANT (S)	8
2.7. TEST METHODOLOGY	8
2.8. SPECIAL ACCESSORIES	8
2.9. EQUIPMENT MODIFICATIONS	-
2.10. ANTENNA REQUIREMENT	
3. MEASUREMENT UNCERTAINTY	9
4. DESCRIPTION OF TEST MODES	10
5. SYSTEM TEST CONFIGURATION	11
5.1. CONFIGURATION OF EUT SYSTEM	11
5.2. EQUIPMENT USED IN TESTED SYSTEM	11
5.3. SUMMARY OF TEST RESULTS	11
6. TEST FACILITY	
7. PEAK OUTPUT POWER	
7.1. MEASUREMENT PROCEDURE	
7.2. TEST SET-UP (BLOCK DIAGRAM OF CONFIGURATION)	13
7.3. LIMITS AND MEASUREMENT RESULT	14
8. 20DB BANDWIDTH	
8.1. MEASUREMENT PROCEDURE	
8.2. TEST SET-UP (BLOCK DIAGRAM OF CONFIGURATION)	
8.3. LIMITS AND MEASUREMENT RESULTS	
9. CONDUCTED SPURIOUS EMISSION	

Further enquiry of validity or verification of the test report should be addressed to AGC by agc01@agccert.com.



9.2. TEST SET-UP (BLOCK DIAGRAM OF CONFIGURATION)	
9.3. MEASUREMENT EQUIPMENT USED	
9.4. LIMITS AND MEASUREMENT RESULT	
10. RADIATED EMISSION	
10.1. MEASUREMENT PROCEDURE	
10.2. TEST SETUP	
10.3. LIMITS AND MEASUREMENT RESULT	
10.4. TEST RESULT	
11. NUMBER OF HOPPING FREQUENCY	40
11.1. MEASUREMENT PROCEDURE	
11.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)	
11.3. MEASUREMENT EQUIPMENT USED	
11.4. LIMITS AND MEASUREMENT RESULT	
12. TIME OF OCCUPANCY (DWELL TIME)	41
12. TIME OF OCCUPANCY (DWELL TIME) 12.1. MEASUREMENT PROCEDURE	
	41
12.1. MEASUREMENT PROCEDURE	41
12.1. MEASUREMENT PROCEDURE	41 41 41
12.1. MEASUREMENT PROCEDURE 12.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION) 12.3. MEASUREMENT EQUIPMENT USED	41 41 41 41
12.1. MEASUREMENT PROCEDURE 12.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION) 12.3. MEASUREMENT EQUIPMENT USED 12.4. LIMITS AND MEASUREMENT RESULT	41 41 41 41 41 41 41
12.1. MEASUREMENT PROCEDURE 12.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION) 12.3. MEASUREMENT EQUIPMENT USED 12.4. LIMITS AND MEASUREMENT RESULT	41 41 41 41 41 45
12.1. MEASUREMENT PROCEDURE	41 41 41 41 45 45 45
<ul> <li>12.1. MEASUREMENT PROCEDURE</li> <li>12.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)</li> <li>12.3. MEASUREMENT EQUIPMENT USED</li> <li>12.4. LIMITS AND MEASUREMENT RESULT</li> <li><b>13. FREQUENCY SEPARATION</b></li> <li>13.1. MEASUREMENT PROCEDURE</li> <li>13.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)</li> </ul>	41 41 41 41 41 45 45 45 45
12.1. MEASUREMENT PROCEDURE 12.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION) 12.3. MEASUREMENT EQUIPMENT USED 12.4. LIMITS AND MEASUREMENT RESULT <b>13. FREQUENCY SEPARATION</b> 13.1. MEASUREMENT PROCEDURE 13.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION) 13.3. MEASUREMENT EQUIPMENT USED	



# **1. VERIFICATION OF CONFORMITY**

Applicant	Shenzhen Hangshi Electronic Technology Co., Ltd	
Applicant		
Address	2nd Floor, A1 Building, G Area, Democracy West Industry Area, Shajing Town,	
	Bao'an District, Shenzhen, China.	
Manufacturer	Shenzhen Hangshi Electronic Technology Co., Ltd	
Address	2nd Floor, A1 Building, G Area, Democracy West Industry Area, Shajing Town,	
Address	Bao'an District, Shenzhen, China.	
Factory	Shenzhen Hangshi Electronic Technology Co., Ltd	
Address	2nd Floor, A1 Building, G Area, Democracy West Industry Area, Shajing Town,	
Address	Bao'an District, Shenzhen, China.	
Product Designation	Wireless Keyboard	
Brand Name	N/A	
Test Model	HD098S-3	
Series Model	HD098S-3G01, UBWDK-01	
Declaration of Difference	All the same except for the model name.	
Date of receipt of test item	Jul. 04, 2023	
Date of test	Jul. 04, 2023 to Jul. 07, 2023	
Deviation	No any deviation from the test method	
Condition of Test Sample	Normal	
Test Result	Pass	
Report Template	AGCRT-US-BR/RF	
	·	

We hereby certify that:

The above equipment was tested by Attestation of Global Compliance (Shenzhen) Co., Ltd. The test data, data evaluation, test procedures, and equipment configurations shown in this report were made in accordance with the procedures given in ANSI C63.10 (2013) and the energy emitted by the sample EUT tested as described in this report is in compliance with radiated emission limits of FCC PART 15.247.

Thea Huang Prepared By Thea Huang Jul. 07, 2023 (Project Engineer) **Reviewed By** Calvin Liu Jul. 07, 2023 (Reviewer) Approved By Max Zhang Jul. 07, 2023 (Authorized Officer)



# 2. GENERAL INFORMATION

# 2.1. PRODUCT DESCRIPTION

The EUT is designed as "Wireless Keyboard". It is designed by way of utilizing the GFSK technology to achieve the system operation.

A major technical description of EUT is described as following

Operation Frequency	2.402 GHz to 2.480 GHz	
RF Output Power	-4.232dBm (Max)	
Bluetooth Version	V5.0	
Modulation	BR ⊠GFSK, EDR □π /4-DQPSK, □8DPSK BLE □GFSK 1Mbps □GFSK 2Mbps	
Number of channels	79	
Hardware Version	V1.0	
Software Version	V1.0	
Antenna Designation	PCB Antenna (Comply with requirements of the FCC part 15.203)	
Antenna Gain	2.34dBi	
Power Supply	DC 3.0V by battery	

#### 2.2. TABLE OF CARRIER FREQUENCYS

Frequency Band	Channel Number	Frequency
	0	2402 MHz
	1	2403 MHz
	:	:
	38	2440 MHz
2402~2480MHz	39	2441 MHz
	40	2442 MHz
	:	:
	77	2479 MHz
	78	2480 MHz



### 2.3. RECEIVER INPUT BANDWIDTH

The input bandwidth of the receiver is 1.3MHz, in every connection one Bluetooth device is the master and the other one is slave. The master determines the hopping sequence. The slave follows this sequence. Both devices shift between RX and TX time slot according to the clock of the master. Additionally, the type of connection (e.g. single of multi slot packet) is set up at the beginning of the connection. The master adapts its hopping frequency and its TX/RX timing according to the packet type of the connection. Also, the slave of the connection will use these settings. Repeating of a packet has no influence on the hopping sequence. The hopping sequence generated by the master of the connection will be followed in any case. That means, a repeated packet will not be send on the same frequency, it is send on the next frequency of the hopping sequence.

#### 2.4. EXAMPLE OF A HOPPING SEQUENCY IN DATA MODE

Example of a hopping sequence in data mode: 40, 21, 44, 23, 04, 15, 66, 56, 19, 78, 07, 28, 69, 55, 36, 45, 05, 13, 43, 74, 57, 35, 67, 76, 02, 34, 54, 63, 42, 11, 30, 06, 64, 25, 75, 48, 17, 33, 58, 01, 29, 14, 51, 72, 03, 31, 50, 61, 77, 18, 10, 47, 12, 68, 08, 49, 20, 00, 73, 09, 16, 60, 71, 41, 24, 53, 38, 26, 46, 37, 65, 32, 70, 52, 27, 59, 22, 62, 39

# 2.5. EQUALLY AVERAGE USE OF FREQUENCIES AND BEHAVIOUR

The generation of the hopping sequence in connection mode depends essentially on two input values:

1. LAP/UAP of the master of the connection.

2. Internal master clock.

The LAP (lower address part) are the 24 LSB's of the 48 BD\_ADDRESS. The BD\_ADDRESS is an unambiguous number of every Bluetooth unit. The UAP (upper address part) are the 24MSB's of the 48BD\_ADDRESS

The internal clock of a Bluetooth unit is derived from a free running clock which is never adjusted and is never turned off. For behavior action with other units only offset is used. It has no relation to the time of the day. Its resolution is at least half the RX/TX slot length of 312.5us. The clock has a cycle of about one day(23h30). In most case it is implemented as 28 bits counter. For the deriving of the hopping sequence the entire. LAP (24 bits),4LSB's(4bits) (Input 1) and the 27MSB's of the clock (Input 2) are used. With this input values different mathematical procedures (permutations, additions, XOR-operations) are performed to generate the Sequence. This will be done at the beginning of every new transmission.

Regarding short transmissions the Bluetooth system has the following behavior:

The first connection between the two devices is established, a hopping sequence was generated. For

Transmitting the wanted data the complete hopping sequence was not used. The connection ended.



The second connection will be established. A new hopping sequence is generated. Due to the fact the Bluetooth clock has a different value, because the period between the two transmission is longer (and it Cannot be shorter) than the minimum resolution of the clock(312.5us). The hopping sequence will always differ from the first one.

# 2.6. RELATED SUBMITTAL(S) / GRANT (S)

This submittal(s) (test report) is intended for **FCC ID: 2AKHJ-HD098S-3** filing to comply with the FCC PART 15.247 requirements.

# 2.7. TEST METHODOLOGY

Both conducted and radiated testing was performed according to the procedures in ANSI C63.10 (2013). Radiated testing was performed at an antenna to EUT distance 3 meters.

#### 2.8. SPECIAL ACCESSORIES

Refer to section 5.2.

# 2.9. EQUIPMENT MODIFICATIONS

Not available for this EUT intended for grant.

#### 2.10. ANTENNA REQUIREMENT

This intentional radiator is designed with a permanently attached antenna of an antenna to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

For more information of the antenna, please refer to the APPENDIX B: PHOTOGRAPHS OF EUT.



# **3. MEASUREMENT UNCERTAINTY**

The reported uncertainty of measurement y ±U, where expended uncertainty U is based on a standard

uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95%.

Item	Measurement Uncertainty
Uncertainty of Conducted Emission for AC Port	$U_c = \pm 3.1 \text{ dB}$
Uncertainty of Radiated Emission below 1GHz	$U_c = \pm 4.0 \text{ dB}$
Uncertainty of Radiated Emission above 1GHz	$U_c = \pm 4.8 \text{ dB}$
Uncertainty of total RF power, conducted	$U_c = \pm 0.8 \text{ dB}$
Uncertainty of RF power density, conducted	$U_c = \pm 2.6 \text{ dB}$
Uncertainty of spurious emissions, conducted	$U_{c} = \pm 2.7 \%$
Uncertainty of Occupied Channel Bandwidth	U <sub>c</sub> = ±2 %



# 4. DESCRIPTION OF TEST MODES

NO.	TEST MODE DESCRIPTION	
1	Low channel GFSK	
2	Middle channel GFSK	
3	High channel GFSK	
4	Hopping mode GFSK	

Note:

- 1. Only the result of the worst case was recorded in the report, if no other cases.
- 2. For Radiated Emission, 3axis were chosen for testing for each applicable mode.
- 3. For Conducted Test method, a temporary antenna connector is provided by the manufacture.

#### Software Setting

BK32xx RF Test - V2.1.0_e	en(Built On Mar 28 2022)		
FTEST			
			1
IC类型: B	K3632 COMM	COM2  Close	
RF HW TEST	SW TEST		Txillit
	Freq 78 TX RX	DateType PN9  Exit Test mode	
Enter DUT	Power 3	PacketType DH5  Config	Rx测试
	AFH 0	DateRate 1Mbps -	Blocking测试
		PacketLen 19	停止
	Hopping BLE		设置Hoping模式
			设置功率
CMD] config,d_mode:1,1 RCV:=]04 0E 04 01 6D 2 RCV:=]04 0E 06 01 1F 20	0 00	l, rx_mode:0, afh:0, jpn:0, ble:0,dr:Mbps.	
CMD] config,d_mode:1,f	freq:78, power:3, p_mode:3, hopping:	I, rx_mode:0, afh:0, jpn:0, ble:0,dr:Mbps.	
RCV:=]04 0E 06 01 1F 20 cc BR hopping	0 OC 3D 30		
CMD] config,d_mode:1,f		I, rx_mode:0, afh:0, jpn:0, ble:0,dr:Mbps.	×
RCV:=]04 0E 04 01 6D 2 RCV:=]04 0E 06 01 1F 20			
fcc_BR_hopping			
	0 00 04 0E 06 01 1F 20 00 98 22 freq:78, power:3, p mode:3, hopping:	I, rx mode:0, afh:0, jpn:0, ble:0,dr:Mbps.	
	0 OC 3D 30	· · · · · · · · · · · · · · · · · · ·	



# 5. SYSTEM TEST CONFIGURATION

#### 5.1. CONFIGURATION OF EUT SYSTEM

Radiated Emission Configure:



## 5.2. EQUIPMENT USED IN TESTED SYSTEM

Item	Equipment	Model No.	ID or Specification	Remark
1	Wireless Keyboard	HD098S-3	2AKHJ-HD098S-3	EUT
2	Control Box	USB-TTL	N/A	AE

**5.3. SUMMARY OF TEST RESULTS** 

FCC RULES	DESCRIPTION OF TEST	RESULT
15.247 (b)(1)	Peak Output Power	Compliant
15.247 (a)(1)	20 dB Bandwidth	Compliant
15.247 (d)	Conducted Spurious Emission	Compliant
15.209	Radiated Emission	Compliant
15.247 (a)(1)(iii)	Number of Hopping Frequency	Compliant
15.247 (a)(1)(iii)	Time of Occupancy	Compliant
15.247 (a)(1)	Frequency Separation	Compliant
15.207	Conducted Emission	Not applicable

Note: The device under test is battery-powered and does not require evaluation of AC Power Line Conducted Emission.



# 6. TEST FACILITY

Test Site	Attestation of Global Compliance (Shenzhen) Co., Ltd
Location	1-2/F, Building 19, Junfeng Industrial Park, Chongqing Road, Heping Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China
Designation Number	CN1259
FCC Test Firm Registration Number	975832
A2LA Cert. No.	5054.02
Description	Attestation of Global Compliance (Shenzhen) Co., Ltd is accredited by A2LA

#### TEST EQUIPMENT OF RADIATED EMISSION TEST

Equipment	Manufacturer	Model	S/N	Cal. Date	Cal. Due
TEST RECEIVER	R&S	ESCI	10096	Feb. 18, 2023	Feb. 17, 2024
EXA Signal Analyzer	Aglient	N9010A	MY53470504	Aug. 04, 2022	Aug. 03, 2023
2.4GHz Filter	EM Electronics	2400-2500	N/A	Mar. 22, 2022	Mar. 21, 2024
Attenuator	ZHINAN	E-002	N/A	Aug. 04, 2022	Aug. 03, 2024
Horn antenna	SCHWARZBECK	BBHA 9170	#768	Oct. 31, 2021	Oct. 30, 2023
Active loop antenna (9K-30MHz)	ZHINAN	ZN30900C	18051	Mar. 12, 2022	Mar. 11, 2024
Double-Ridged Waveguide Horn	ETS LINDGREN	3117	00034609	Mar. 23, 2023	Mar. 22, 2024
Broadband Preamplifier	ETS LINDGREN	3117PA	00225134	Sep. 02, 2022	Sep. 01, 2024
ANTENNA	SCHWARZBECK	VULB9168	494	Jan. 05, 2023	Jan. 04, 2025
Test software	Tonscend	JS32-RE (Ver.2.5)	N/A	N/A	N/A



# 7. PEAK OUTPUT POWER

# 7.1. MEASUREMENT PROCEDURE

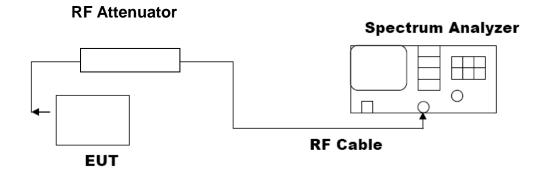
For peak power test:

- 1. Connect EUT RF output port to the Spectrum Analyzer through an RF attenuator
- 2. Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel.
- 3. RBW > 20 dB bandwidth of the emission being measured.
- 4. VBW  $\geq$ RBW.
- 5. Sweep: Auto.
- 6. Detector function: Peak.
- 7. Trace: Max hold.

Allow trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission. The indicated level is the peak output power, after any corrections for external attenuators and cables.

# 7.2. TEST SET-UP (BLOCK DIAGRAM OF CONFIGURATION)

# PEAK POWER TEST SETUP





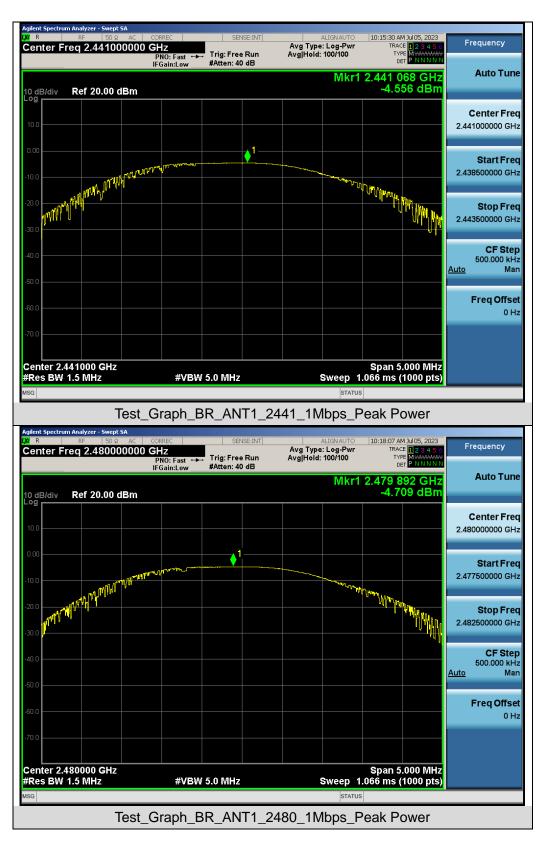
#### 7.3. LIMITS AND MEASUREMENT RESULT

Test Data of Conducted Output Power							
Test Mode	Test Channel (MHz)	Peak Power (dBm)	Limits (dBm)	Pass or Fail			
	2402	-4.232	≤21	Pass			
GFSK	2441	-4.556	≤21	Pass			
	2480	-4.709	≤21	Pass			

#### **Test Graphs of Conducted Output Power**







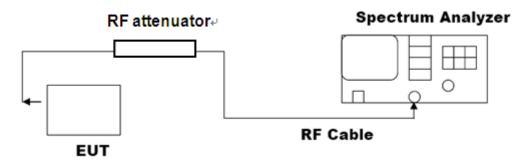


# 8. 20DB BANDWIDTH

#### **8.1. MEASUREMENT PROCEDURE**

- 1. Connect EUT RF output port to the Spectrum Analyzer through an RF attenuator
- 2, Set the EUT Work on the top, the middle and the bottom operation frequency individually.
- 3. Set Span = approximately 2 to 5 times the 20 dB bandwidth, centered on a hoping channel The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW; Sweep = auto; Detector function = peak
- 4. Set SPA Trace 1 Max hold, then View.

# 8.2. TEST SET-UP (BLOCK DIAGRAM OF CONFIGURATION)

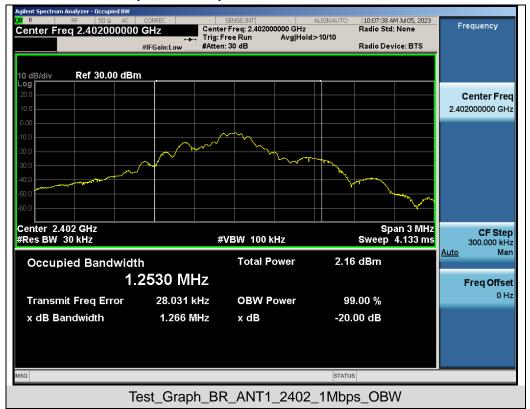




#### **8.3. LIMITS AND MEASUREMENT RESULTS**

Test Data of Occupied Bandwidth and -20dB Bandwidth							
Test Mode	-20dB Bandwidth (MHz)	Limits	Pass or Fail				
	2402	1.253	1.266	N/A	Pass		
GFSK	2441	1.252	1.326	N/A	Pass		
	2480	1.169	1.251	N/A	Pass		

#### Test Graphs of Occupied Bandwidth and -20 Bandwidth









# 9. CONDUCTED SPURIOUS EMISSION

# 9.1. MEASUREMENT PROCEDURE

- 1. Connect EUT RF output port to the Spectrum Analyzer through an RF attenuator
- 2. Set the EUT Work on the top, the Middle and the bottom operation frequency individually.
- Set the Span = wide enough to capture the peak level of the in-band emission and all spurious emissions from the lowest frequency generated in the EUT up through the 10th harmonic.
   RBW = 100 kHz; VBW= 300 kHz; Sweep = auto; Detector function = peak.
- 4. Set SPA Trace 1 Max hold, then View.

#### 9.2. TEST SET-UP (BLOCK DIAGRAM OF CONFIGURATION)

The same as described in section 8.2

#### 9.3. MEASUREMENT EQUIPMENT USED

The same as described in section 6

#### 9.4. LIMITS AND MEASUREMENT RESULT

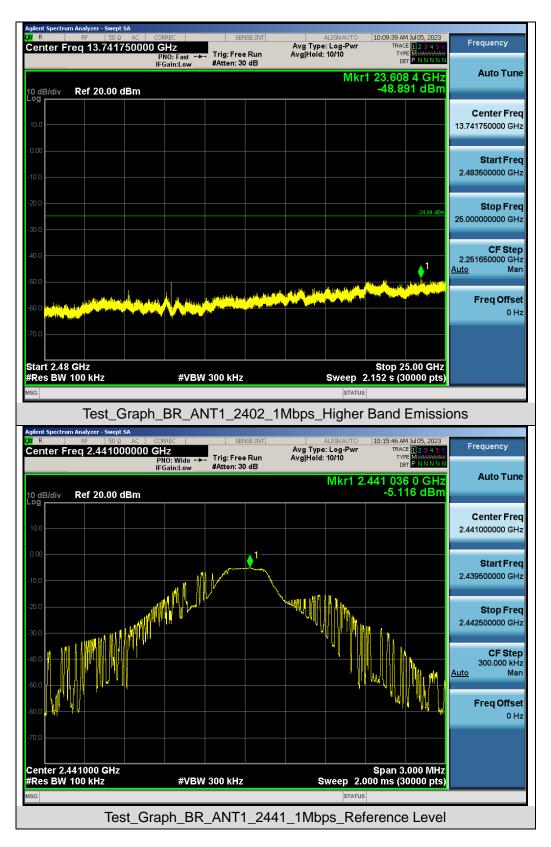
LIMITS AND MEASUREMENT RESULT						
Applieghte Limite	Measurement Result					
Applicable Limits	Test Data	Criteria				
In any 100 kHz Bandwidth Outside the	At least -20dBc than the limit					
frequency band in which the spread spectrum	Specified on the BOTTOM	PASS				
intentional radiator is operating, the radio frequency	Channel					
power that is produce by the intentional radiator shall be at least 20 dB below that in 100KHz bandwidth within the band that contains the highest level of the desired power. In addition, radiation emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in§15.209(a))	At least -20dBc than the limit Specified on the TOP Channel	PASS				



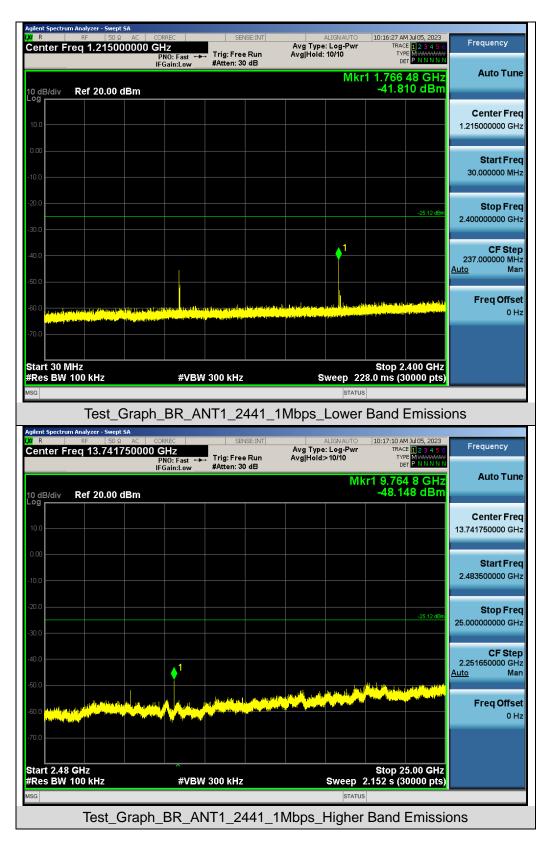


#### Test Graphs of Spurious Emissions in Non-Restricted Frequency Bands

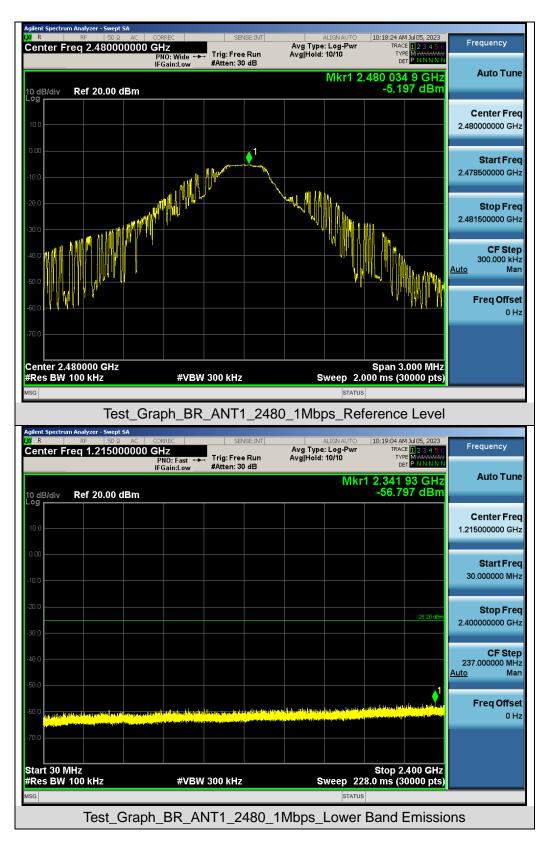














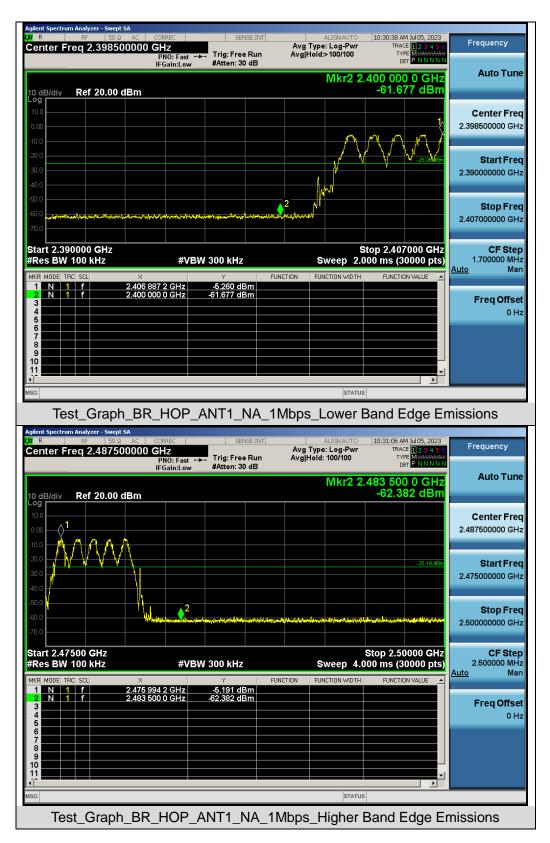
	ım Analyzer - Swept									
X/ R Center F	RF 50 Ω reg 13.7500	AC COR			JSE:INT		ALIGNAUTO pe: Log-Pwr	TRAC	1 Jul 05, 2023 E 1 2 3 4 5 6	Frequency
		PI	IO:Fast ↔► Gain:Low	Trig: Free #Atten: 30		Avg Ho	ld:>10/10	TYF	E MWWWWWW T P N N N N N	
		IFC	Jam.Low	ar lecoli i o	~ 4 <u>D</u>		Mkr	1 24.784		Auto Tune
10 dB/div	Ref 20.00 d	Bm					INTRO		61 dBm	
40.0										Center Freq
10.0										13.750000000 GHz
0.00										
0.00										Start Free
-10.0										2.500000000 GH
-20.0										Stop Free
									-25.20 dBm	25.000000000 GH
-30.0										
										CF Ster
-40.0									1	2.250000000 GH
										<u>Auto</u> Mar
-50.0					المحمد	in the Charles	and the second second	a dia dia dia dia dia dia dia dia dia di		
-60.0 <b></b>	والمور المراجعة المحاصر والمراجع والمراجع	ر الغاني الأراكيني.			and a second second Second second		the state of the state	a superior		Freq Offse
National Providence		Carlos Carlos	Contractor of the second							0 H:
70.0										
								<b>0</b> 1 0		
Start 2.50 #Res BW			#VBM	300 kHz			Sweep 2	Stop 2 2.152 s./3	5.00 GHz 0000 nts)	
ISG							STATUS		, and a pres)	
	Test_C	Graph_	BR_AN	VT1_24	480_1	Mbps_	_Higher	Band	Emissio	ons





#### Test Graphs of Band Edge Emissions in Non-Restricted Frequency Bands







# **10. RADIATED EMISSION**

### **10.1. MEASUREMENT PROCEDURE**

- 1. The EUT was placed on the top of the turntable 0.8 or 1.5 meter above ground. The phase center of the receiving antenna mounted on the top of a height-variable antenna tower was placed 3 meters far away from the turntable.
- 2. Power on the EUT and all the supporting units. The turntable was rotated by 360 degrees to determine the position of the highest radiation.
- 3. The height of the broadband receiving antenna was varied between one meter and four meters above ground to find the maximum emissions field strength of both horizontal and vertical polarization.
- 4. For each suspected emission, the antenna tower was scan (from 1 M to 4 M) and then the turntable was rotated (from 0 degree to 360 degrees) to find the maximum reading.
- 5. Set the test-receiver system to Peak or CISPR quasi-peak Detect Function with specified bandwidth under Maximum Hold Mode.
- 6. For emissions above 1GHz, use 1MHz RBW and 3MHz VBW for peak reading. Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.
- 7. When the radiated emissions limits are expressed in terms of the average value of the emissions, and pulsed operation is employed, the measurement field strength shall be determined by averaging over one complete pulse train, including blanking intervals, as long as the pulse train does not exceed 0.1 seconds. As an alternative (provided the transmitter operates for longer than 0.1 seconds) or in cases where the pulse train exceeds 0.1 seconds, the measured field strength shall be determined from the average absolute voltage during a 0.1 second interval during which the field strength is at its maximum values.
- 8. If the emissions level of the EUT in peak mode was 3 dB lower than the average limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 3 dB margin will be repeated one by one using the quasi-peak method for below 1GHz.
- 9. For testing above 1GHz, the emissions level of the EUT in peak mode was lower than average limit (that means the emissions level in peak mode also complies with the limit in average mode), then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions will be measured in average mode again and reported.
- 10. In case the emission is lower than 30MHz, loop antenna has to be used for measurement and the recorded data should be QP measured by receiver. High Low scan is not required in this case.



The following table is the setting of spectrum analyzer and receiver.

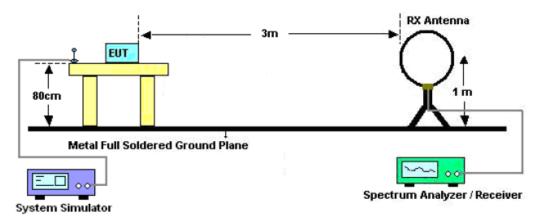
Spectrum Parameter	Setting
Start ~Stop Frequency	9KHz~150KHz/RB 200Hz for QP
Start ~Stop Frequency	150KHz~30MHz/RB 9KHz for QP
Start ~Stop Frequency	30MHz~1000MHz/RB 120KHz for QP
Start ~Stop Frequency	1GHz~26.5GHz 1MHz/3MHz for Peak, 1MHz/3MHz for Average

Receiver Parameter	Setting
Start ~Stop Frequency	9KHz~150KHz/RB 200Hz for QP
Start ~Stop Frequency	150KHz~30MHz/RB 9KHz for QP
Start ~Stop Frequency	30MHz~1000MHz/RB 120KHz for QP

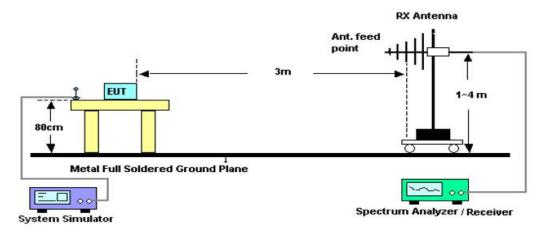


#### **10.2. TEST SETUP**

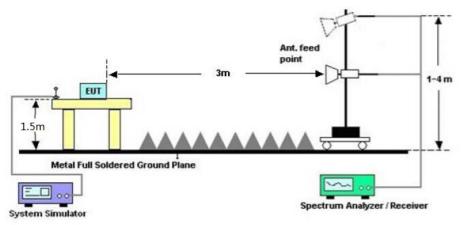
Radiated Emission Test-Setup Frequency Below 30MHz



#### RADIATED EMISSION TEST SETUP 30MHz-1000MHz



#### RADIATED EMISSION TEST SETUP ABOVE 1000MHz





#### **10.3. LIMITS AND MEASUREMENT RESULT**

15.209 Limit in the below table has to be followed

Frequencies (MHz)	Field Strength (microvolts/meter)	Measurement Distance (meters)
0.009~0.490	2400/F(kHz)	300
0.490~1.705	24000/F(kHz)	30
1.705~30.0	30	30
30~88	100	3
88~216	150	3
216~960	200	3
Above 960	500	3

Note: All modes were tested for restricted band radiated emission, the test records reported below are the worst result compared to other modes.

# 10.4. TEST RESULT

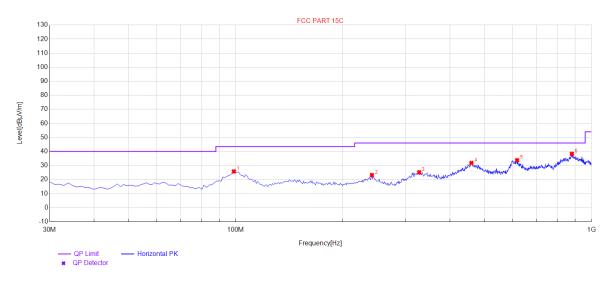
#### Radiated emission below 30MHz

The amplitude of spurious emissions from 9kHz to 30MHz which are attenuated more than 20 dB below the permissible value need not be reported.



EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 1	Antenna	Horizontal

#### Radiated emission from 30MHz to 1000MHz

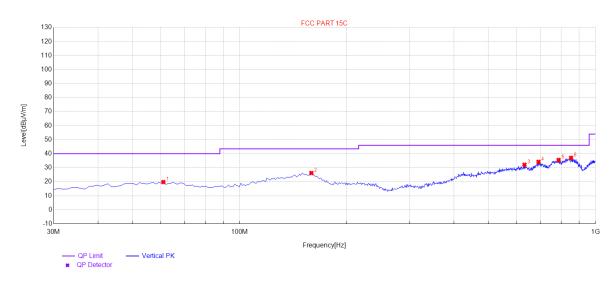


NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	98.87	25.81	20.81	43.50	17.69	100	330	Horizontal
2	241.46	23.21	17.26	46.00	22.79	100	130	Horizontal
3	327.79	25.18	21.14	46.00	20.82	100	260	Horizontal
4	459.71	31.83	27.60	46.00	14.17	100	290	Horizontal
5	617.82	33.78	28.08	46.00	12.22	100	40	Horizontal
6	880.69	38.33	33.22	46.00	7.67	100	200	Horizontal

#### **RESULT: PASS**



EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 1	Antenna	Vertical



NO.	Freq. [MHz]	Level [dBµV/m]	Factor [dB]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	61.04	19.78	14.77	40.00	20.22	100	320	Vertical
2	159.01	26.22	21.84	43.50	17.28	100	310	Vertical
3	631.4	32.12	26.42	46.00	13.88	100	70	Vertical
4	691.54	34.21	28.58	46.00	11.79	100	0	Vertical
5	787.57	35.52	30.42	46.00	10.48	100	140	Vertical
6	853.53	37.02	32.18	46.00	8.98	100	170	Vertical

# **RESULT: PASS**

Note: 1. Factor=Antenna Factor + Cable loss, Margin= Limit-Level.

2. All test modes had been pre-tested. The mode 1 is the worst case and recorded in the report.



#### Radiated emission above 1GHz

EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 1	Antenna	Horizontal

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Value Type	
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	value Type	
4804.000	44.63	0.08	44.71	74	-29.29	peak	
4804.000	37.52	0.08	37.6	54	-16.4	AVG	
7206.000	40.48	2.21	42.69	74	-31.31	peak	
7206.000	32.31	2.21	34.52	54	-19.48	AVG	
Remark:					1		
Factor = Antenna Factor + Cable Loss – Pre-amplifier.							

EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 1	Antenna	Vertical

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Value Type	
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	value Type	
4804.000	43.47	0.08	43.55	74	-30.45	peak	
4804.000	36.28	0.08	36.36	54	-17.64	AVG	
7206.000	40.63	2.21	42.84	74	-31.16	peak	
7206.000	31.45	2.21	33.66	54	-20.34	AVG	
Remark:							
Factor = Anten	Factor = Antenna Factor + Cable Loss – Pre-amplifier.						



EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 2	Antenna	Horizontal

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Value Type
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	value Type
4882.000	45.78	0.14	45.92	74	-28.08	peak
4882.000	38.41	0.14	38.55	54	-15.45	AVG
7323.000	41.56	2.36	43.92	74	-30.08	peak
7323.000	34.69	2.36	37.05	54	-16.95	AVG
Remark:	•			L	1	
Factor = Anter	na Factor + Cabl	e Loss – Pre-	amplifier.			

EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 2	Antenna	Vertical

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Value Type
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	value Type
4882.000	45.69	0.14	45.83	74	-28.17	peak
4882.000	37.48	0.14	37.62	54	-16.38	AVG
7323.000	40.52	2.36	42.88	74	-31.12	peak
7323.000	33.41	2.36	35.77	54	-18.23	AVG
Remark:						
actor = Anter	nna Factor + Cabl	e Loss – Pre-	amplifier.			



EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 3	Antenna	Horizontal

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Value Type
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	value Type
4960.000	46.85	0.22	47.07	74	-26.93	peak
4960.000	38.45	0.22	38.67	54	-15.33	AVG
7440.000	41.62	2.64	44.26	74	-29.74	peak
7440.000	32.89	2.64	35.53	54	-18.47	AVG
Remark:			•		•	•
actor = Antenna Factor + Cable Loss – Pre-amplifier.						

EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 3	Antenna	Vertical

Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	
(MHz)	(dBµV)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	Value Type
4960.000	46.79	0.22	47.01	74	-26.99	peak
4960.000	38.86	0.22	39.08	54	-14.92	AVG
7440.000	40.45	2.64	43.09	74	-30.91	peak
7440.000	31.56	2.64	34.2	54	-19.8	AVG
Remark:						
actor = Anter	nna Factor + Cable	e Loss – Pre-	amplifier.			

#### **RESULT: PASS**

Note:

The amplitude of other spurious emissions from 1G to 25 GHz which are attenuated more than 20 dB below the

permissible value need not be reported.

Factor = Antenna Factor + Cable loss - Amplifier gain, Margin=Level-Limit.

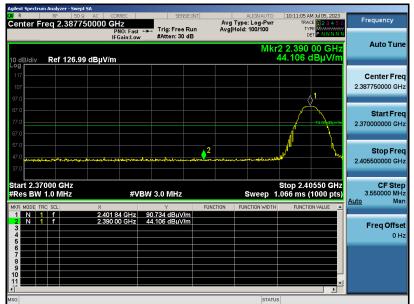
The "Factor" value can be calculated automatically by software of measurement system.



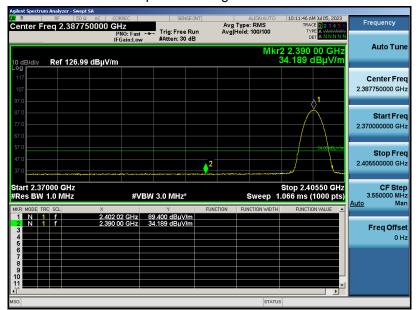
EUT	Wireless Keyboard	Model Name	HD098S-3		
Temperature	25°C	Relative Humidity	55.4%		
Pressure	960hPa	Test Voltage	Normal Voltage		
Test Mode	Mode 1	Antenna	Horizontal		

#### Test result for band edge emission at restricted bands

#### Test Graph for Peak Measurement



Test Graph for Average Measurement



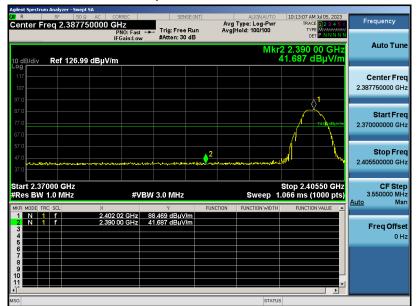
#### **RESULT: PASS**



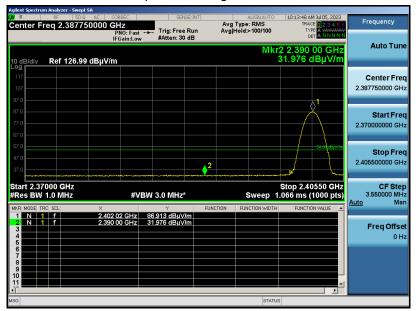
#### Report No.: AGC00803230701FE03 Page 37 of 46

EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 1	Antenna	Vertical

Test Graph for Peak Measurement



Test Graph for Average Measurement



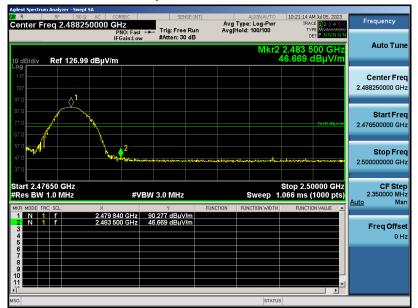
**RESULT: PASS** 



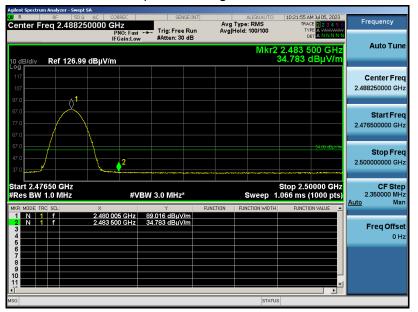
#### Report No.: AGC00803230701FE03 Page 38 of 46

EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 3	Antenna	Horizontal

Test Graph for Peak Measurement



Test Graph for Average Measurement



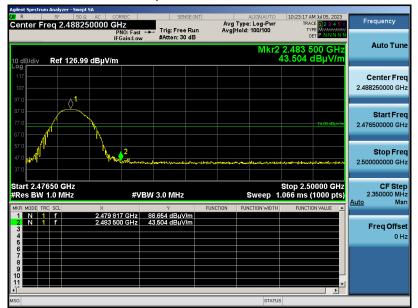
#### **RESULT: PASS**



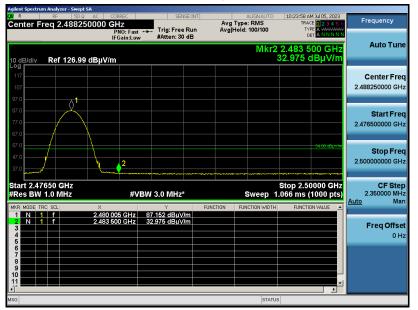
#### Report No.: AGC00803230701FE03 Page 39 of 46

EUT	Wireless Keyboard	Model Name	HD098S-3
Temperature	25°C	Relative Humidity	55.4%
Pressure	960hPa	Test Voltage	Normal Voltage
Test Mode	Mode 3	Antenna	Vertical

Test Graph for Peak Measurement



Test Graph for Average Measurement



#### **RESULT: PASS**



# **11. NUMBER OF HOPPING FREQUENCY**

### **11.1. MEASUREMENT PROCEDURE**

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen.

2. RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.

3. VBW  $\geq$  RBW. Sweep: Auto. Detector function: Peak. Trace: Max hold.

4. Allow the trace to stabilize.

#### **11.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)**

Same as described in section 8.2

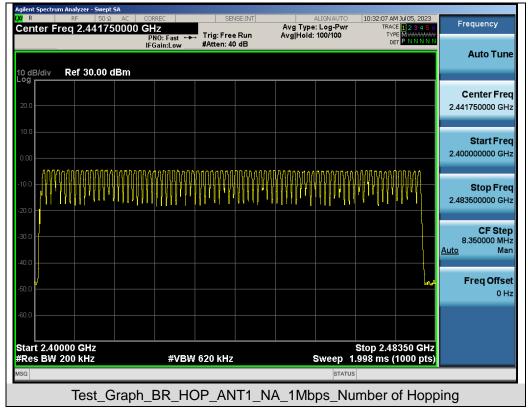
#### **11.3. MEASUREMENT EQUIPMENT USED**

The same as described in section 6

#### **11.4. LIMITS AND MEASUREMENT RESULT**

Test Data of Number of Hopping Frequency					
Test Mode Number of Hopping Frequency Limits Pass or Fail					
GFSK Hopping	79	>=15	Pass		

#### Test Graphs of Number of Hopping Frequency





# 12. TIME OF OCCUPANCY (DWELL TIME)

# 12.1. MEASUREMENT PROCEDURE

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span: Zero span, centered on a hopping channel.

2. RBW shall be  $\leq$  channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel.

3. Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel.

4. Detector function: Peak. Trace: Max hold.

5. Use the marker-delta function to determine the transmit time per hop.

6. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements. Determine the number of hops over the sweep time and calculate the total number of hops in the period specified in the requirements, using the following equation:

(Number of hops in the period specified in the requirements) = (number of hops on spectrum analyzer)  $\times$  (period specified in the requirements / analyzer sweep time)

7. The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hops in the period specified in the requirements.

# 12.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)

Same as described in section 8.2

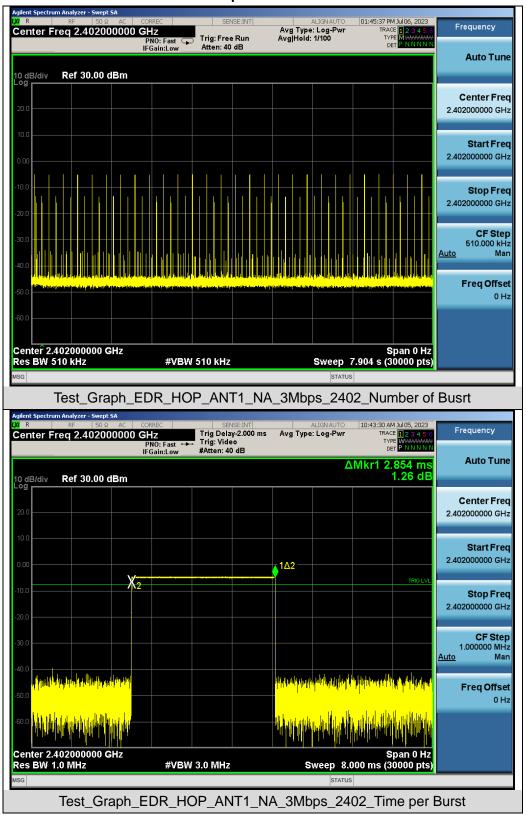
#### **12.3. MEASUREMENT EQUIPMENT USED**

The same as described in section 6

#### **12.4. LIMITS AND MEASUREMENT RESULT**

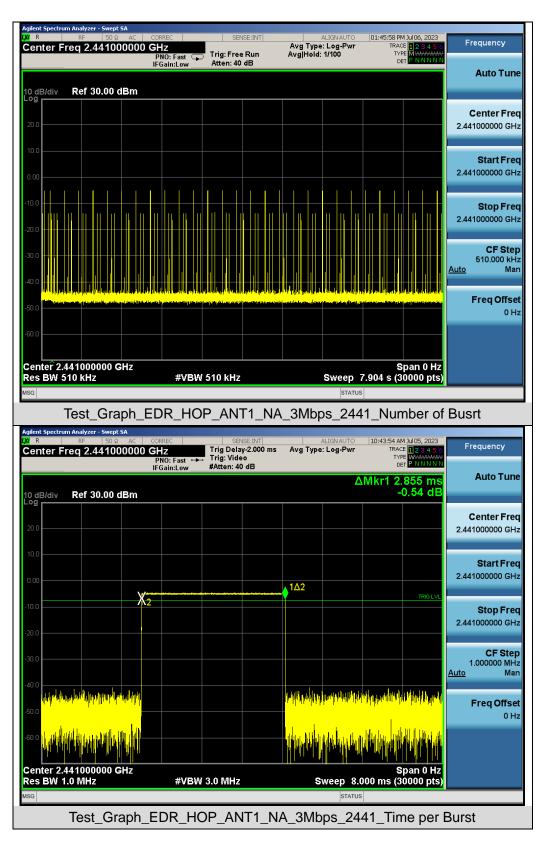
Test Data of Dwell Time					
Channel	Time of Pulse for DH5 (ms)	Number of hops in the period specified in the requirements	Sweep Time (ms)	Limit (ms)	Pass or Fail
2402	2.854	28.0*4	319.648	400	Pass
2441	2.855	29.0*4	331.180	400	Pass
2480	2.854	29.0*4	331.064	400	Pass



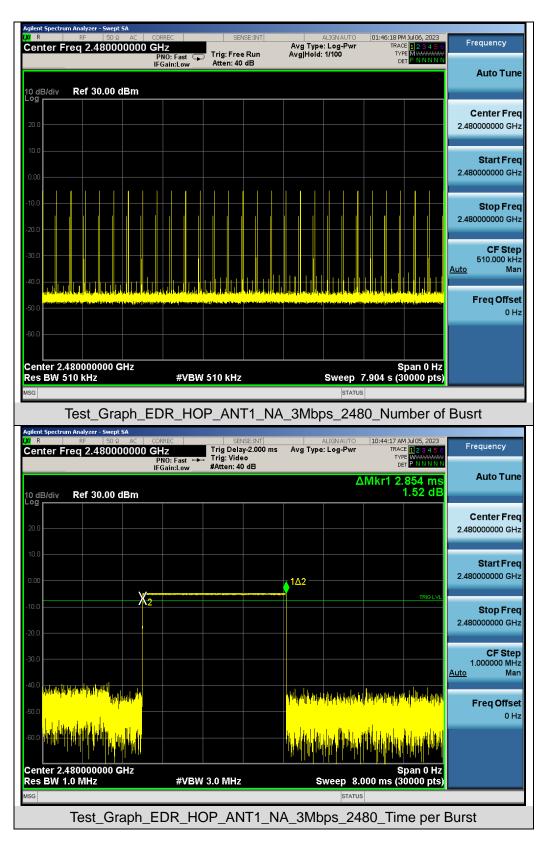


#### Test Graphs of Dwell Time











# **13. FREQUENCY SEPARATION**

# **13.1. MEASUREMENT PROCEDURE**

The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span: Wide enough to capture the peaks of two adjacent channels.

2. RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel.

3. Video (or average) bandwidth (VBW)  $\geq$  RBW.

4. Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize.

Use the marker-delta function to determine the separation between the peaks of the adjacent channels.

#### 13.2. TEST SETUP (BLOCK DIAGRAM OF CONFIGURATION)

Same as described in section 6.2

#### **13.3. MEASUREMENT EQUIPMENT USED**

The same as described in section 6.3

#### **13.4. LIMITS AND MEASUREMENT RESULT**

Test Data of Frequency Separation					
Test Mode	Limits	Pass or Fail			
GFSK Hopping	0.985	>= 2/3 -20dB BW	Pass		



#### **Test Graphs of Number of Hopping Frequency**



# APPENDIX A: PHOTOGRAPHS OF TEST SETUP

Refer to the Report No.: AGC00803230701AP02

# APPENDIX B: PHOTOGRAPHS OF EUT

Refer to the Report No.: AGC00803230701AP03

----END OF REPORT----



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